Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/500,287	SASAKI ET AL.	
Examiner	Art Unit	
Wen-Ying P. Chen	2871	

	SEARCHED		
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
Citations search from IDS documents	10/3/2005	WPC
key words search in US- PGPUB,USPAT,USOCR,EPO,JPO,D ERWENT,IBM_TDB databases in EAST: see search history printout	10/3/2005	WPC
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